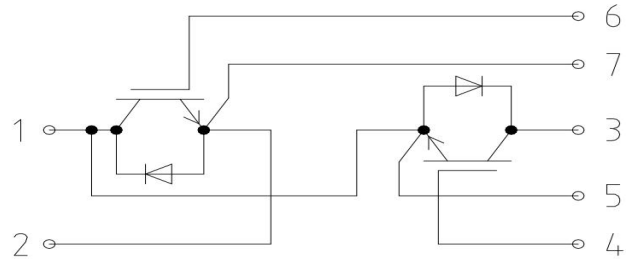


PRODUCT FEATURES

- IGBT CHIP(Trench+FS)
- Low saturation voltage and positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Ultra Low Loss,High Ruggedness
- High short circuit capability


APPLICATIONS

- High frequency switching application
- Medical applications
- Motion/servo control
- UPS systems


IGBT

 ABSOLUTE MAXIMUM RATINGS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit
V_{CES}	Collector Emitter Voltage	1700	V
V_{GES}	Gate Emitter Voltage	± 20	
I_c	DC Collector Current	$T_C = 25^\circ C, T_{Jmax} = 175^\circ C$	450
		$T_C = 100^\circ C, T_{Jmax} = 175^\circ C$	300
I_{CM}	Repetitive Peak Collector Current	$t_p = 1\text{ ms}$	600
P_{tot}	Power Dissipation Per IGBT	$T_C = 25^\circ C, T_{Jmax} = 175^\circ C$	2

Diode

 ABSOLUTE MAXIMUM RATINGS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit
V_{RRM}	Repetitive Reverse Voltage	1700	V
$I_{F(AV)}$	Average Forward Current	300	A
I_{FRM}	Repetitive Peak Forward Current	$t_p = 1\text{ ms}$	
I^2t		$T_J = 150^\circ C, t = 10\text{ms}, V_R = 0V$	19.8

MODULE CHARACTERISTICS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit
T_{Jmax}	Max. Junction Temperature	175	$^\circ C$
T_{Jop}	Operating Temperature	-40~150	
T_{stg}	Storage Temperature	-40~125	
V_{isol}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), $t = 1\text{ minute}$	4000
CTI	Comparative Tracking Index		>200
Torque	to heatsink	Recommended (M6)	3~5
	to terminal	Recommended (M6)	3~5
Weight			320

IGBT

 ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/ Test Conditions		Min.	Typ.	Max.	Unit
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=6\text{mA}$	5.3	5.8	6.3	V
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$I_C=300\text{A}, V_{GE}=15\text{V}, T_J=25^\circ\text{C}$		1.85	2.2	
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_J=125^\circ\text{C}$		2.05		
		$I_C=300\text{A}, V_{GE}=15\text{V}, T_J=150^\circ\text{C}$		2.15		
I_{CES}	Collector Leakage Current	$V_{CE}=1700\text{V}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$			1	mA
		$V_{CE}=1700\text{V}, V_{GE}=0\text{V}, T_J=150^\circ\text{C}$			10	mA
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 20\text{V}, T_J=25^\circ\text{C}$			± 500	nA
R_{gint}	Integrated Gate Resistor			1.8		Ω
Q_g	Gate Charge	$V_{CE}=900\text{V}, I_C=300\text{A}, V_{GE}=15\text{V}$		3.2		μC
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		28.4		nF
C_{res}	Reverse Transfer Capacitance				900	
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=900\text{V}, I_C=300\text{A}$ $R_G=5\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=25^\circ\text{C}$	200		ns
			$T_J=150^\circ\text{C}$	220		ns
t_r	Rise Time		$T_J=25^\circ\text{C}$	165		ns
			$T_J=150^\circ\text{C}$	180		ns
$t_{d(off)}$	Turn off Delay Time	$T_J=25^\circ\text{C}$	650		ns	
		$T_J=150^\circ\text{C}$	720		ns	
t_f	Fall Time	$T_J=25^\circ\text{C}$	240		ns	
		$T_J=150^\circ\text{C}$	360		ns	
E_{on}	Turn on Energy	$T_J=25^\circ\text{C}$	150		mJ	
		$T_J=150^\circ\text{C}$	200		mJ	
E_{off}	Turn off Energy	$T_J=25^\circ\text{C}$	60		mJ	
		$T_J=150^\circ\text{C}$	100		mJ	
I_{SC}	Short Circuit Current	$t_{psc} \leq 10\mu\text{S}, V_{GE}=15\text{V}$ $T_J=150^\circ\text{C}, V_{CC}=900\text{V}$		1200		A
R_{thJC}	Junction to Case Thermal Resistance (Per IGBT)				0.14	K /W

Diode-inverter

ELECTRICAL CHARACTERISTICS (T_C =25°C unless otherwise specified)

Symbol	Parameter/ Test Conditions	Min.	Typ.	Max.	Unit	
V _F	Collector Emitter Voltage	I _F =300A, V _{GE} =0V, T _J = 2 5 °C		1.8	2.2	V
		I _F =300A, V _{GE} =0V, T _J = 1 2 5 °C		1.95		
		I _F =300A, V _{GE} =0V, T _J = 1 5 0 °C		1.9		
T _{rr}	Gate Emitter Voltage		1300		nS	
I _{RRM}	DC Collector Current I _F =300A , V _R =900V di _F /dt=-1500A/μs T _J =150°C		230		A	
Q _{RR}		Repetitive Peak Collector Current		160	μC	
E _{rec}		Power Dissipation Per IGBT		65		mJ
R _{thJCD}		Junctionto CaseThermal Resistance (Per Diode)			0.15	kW

IGBT Typical Performance

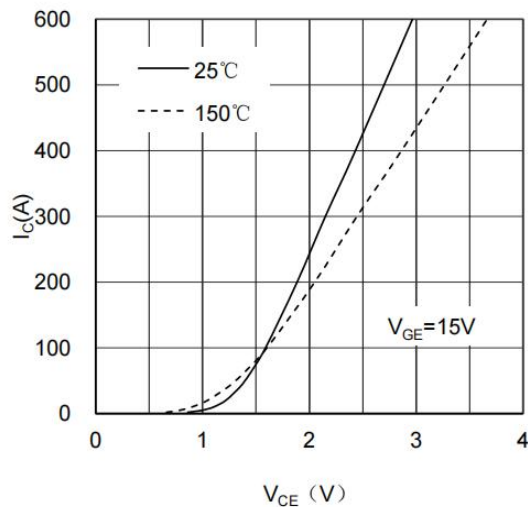


Figure1 Typical Output Characteristics IGBT-inverter

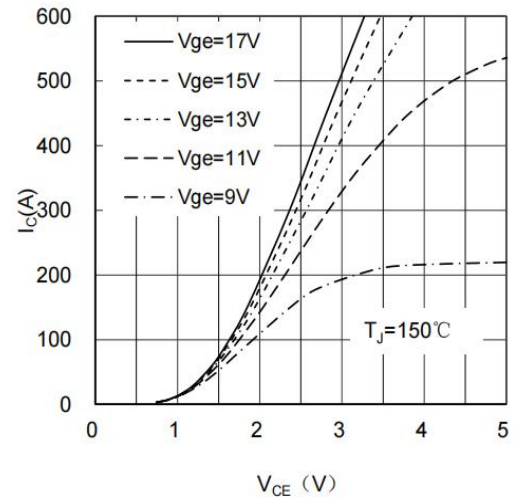


Figure2 Typical Output Characteristics IGBT-inverter

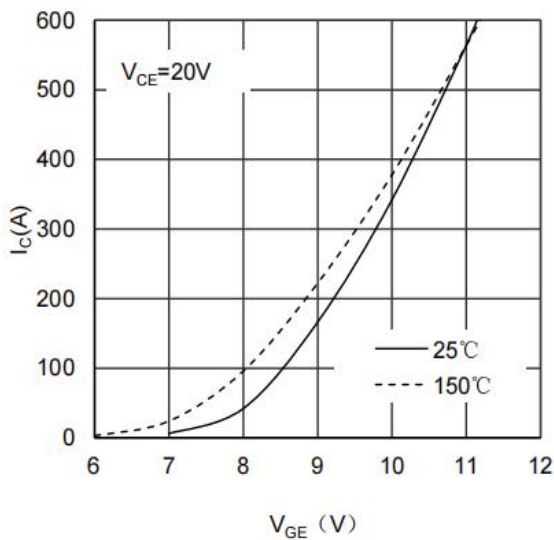


Figure3 Typical Transfer characteristics IGBT-inverter

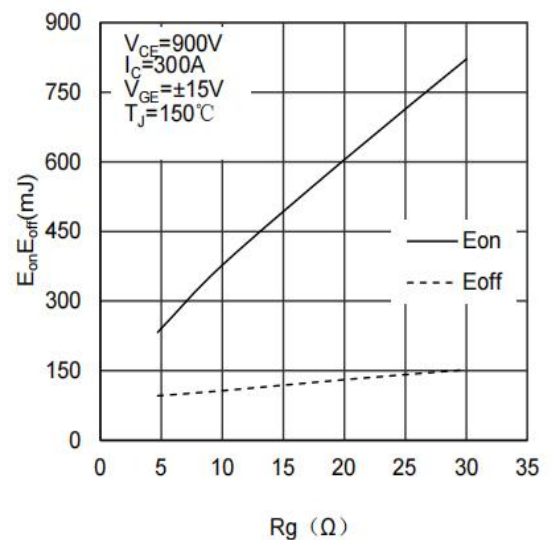


Figure4 Switching Energy vs Gate Resistor IGBT-inverter

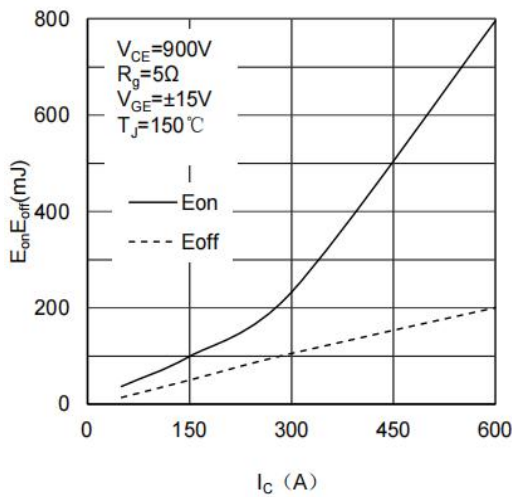


Figure5 Switching Energy vs Collector Current IGBT-inverter

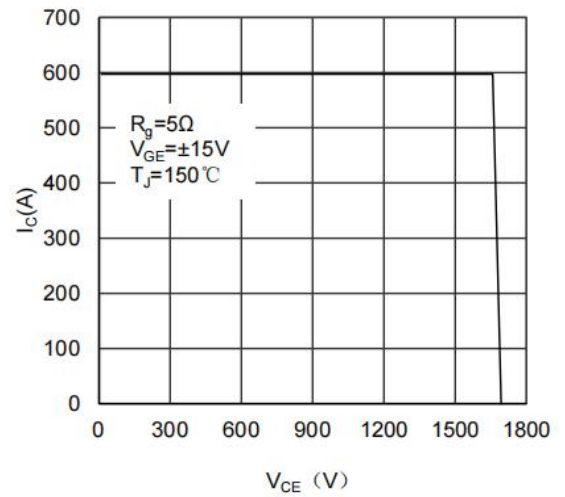


Figure6 Reverse Biased Safe Operating Area IGBT-inverter

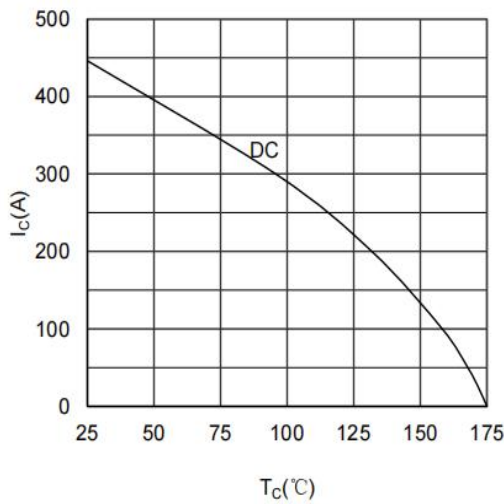


Figure7 Collector Current vs Case temperature IGBT-inverter

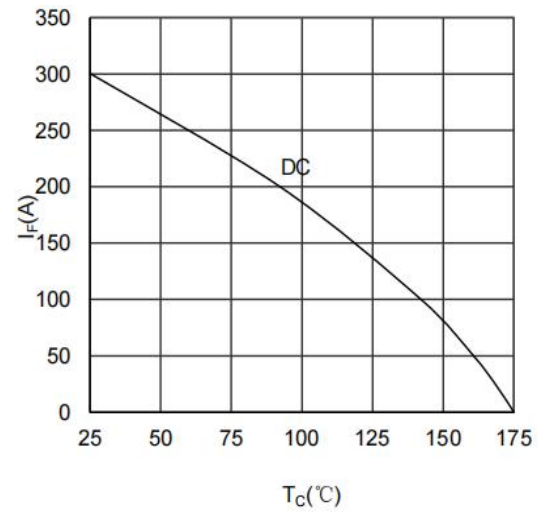


Figure8 Forward current vs Case temperature Diode-inverter

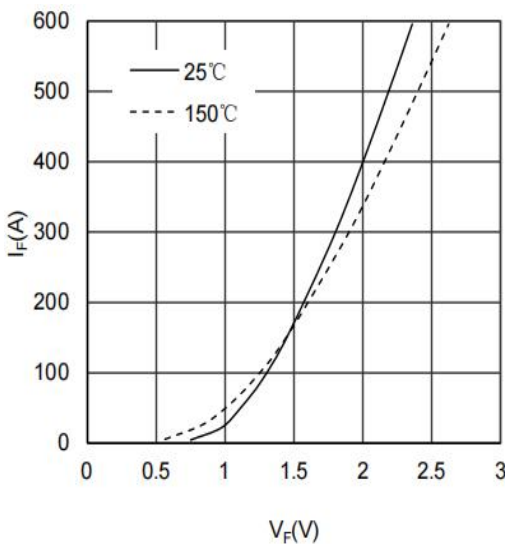


Figure9 Diode Forward Characteristics Diode-inverter

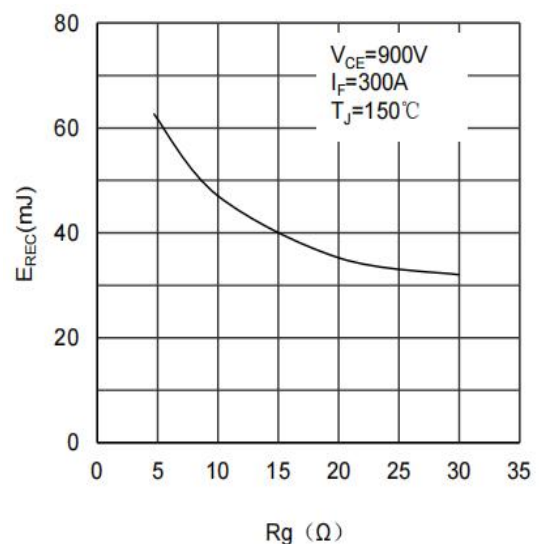


Figure10 Switching Energy vs Gate Resistor Diode-inverter

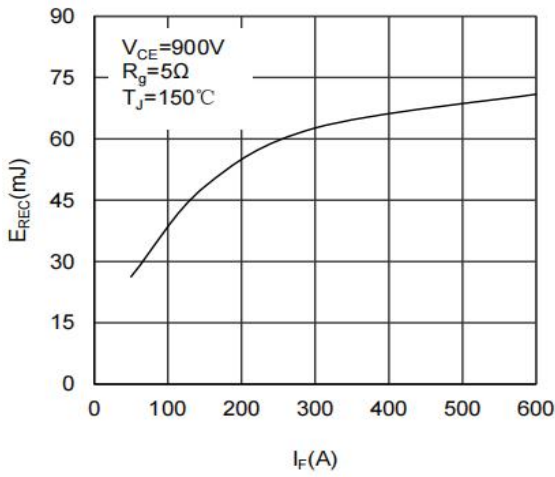


Figure11 Switching Energy vs Forward Current Diode-inverter

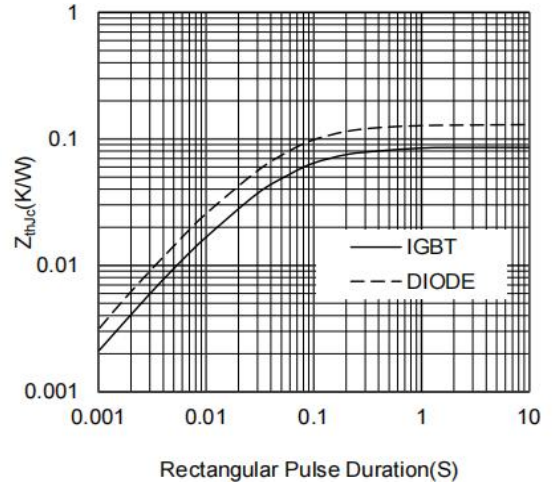


Figure12 Transient Thermal Impedance of Diode and IGBT-inverter

